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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/075,390	02/15/2002	Kristy A. Campbell	M4065.0505/P505	7206	
24998	7590 08/18/2004		EXAMINER		
	DICKSTEIN SHAPIRO MORIN & OSHINSKY LLP 2101 L STREET NW			RICHARDS, N DREW	
	ON, DC 20037-1526		ART UNIT	PAPER NUMBER	
	•		2815		

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/075,390	CAMPBELL ET AL.			
Office Action Summary	Examiner	Art Unit			
	N. Drew Richards	2815			
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).  Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).					
Status					
1) Responsive to communication(s) filed on 14 Ju	<u>ıly 2004</u> .				
2a) ☑ This action is <b>FINAL</b> . 2b) ☐ This	•				
	Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.				
Disposition of Claims					
<ul> <li>4) ⊠ Claim(s) 1,3-5 and 7-33 is/are pending in the application.</li> <li>4a) Of the above claim(s) is/are withdrawn from consideration.</li> <li>5) ⊠ Claim(s) 1,3,7-19,22,28,29 and 33 is/are allowed.</li> <li>6) ⊠ Claim(s) 4,5,20,21,23-27,31 and 32 is/are rejected.</li> <li>7) ⊠ Claim(s) 30 is/are objected to.</li> <li>8) ☐ Claim(s) are subject to restriction and/or election requirement.</li> </ul>					
Application Papers					
9)  The specification is objected to by the Examiner.					
10)⊠ The drawing(s) filed on <u>14 July 2004</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).  11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119					
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>					
Attachment(s)					
1) Notice of References Cited (PTO-892)  4) Interview Summary (PTO-413)					
<ul> <li>2) Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)</li> <li>Paper No(s)/Mail Date 6/9/04 and 7/26/04.</li> </ul>	Paper No(s)/Mail Da 5)  Notice of Informal P 6) Other:	te atent Application (PTO-152)			

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#### **DETAILED ACTION**

# Claim Rejections - 35 USC § 112

1. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

2. Claim 4 recites the limitation "said glass material" in line 2. There is insufficient antecedent basis for this limitation in the claim. Claim 5 includes the same limitations as claim 4 and thus is also rejected for insufficient antecedent basis.

# Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 20, 21, 23-25 and 27 are rejected under 35 U.S.C. 103(a) as being unpatentable over WO 00/48196 A1 in view of Sandhu et al. (U.S. Patent No. 5,837,564).

WO 00/48916 A1 (here after "'196") teaches a method of forming a resistance variable memory element comprising:

forming a first electrode 130 (figure 1, page 8 line 23);

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forming an insulating layer 150 over the first electrode 130 (figure 1, page 8 line 25);

etching an opening in the insulating layer 150 to expose the first electrode 130 (figure 1, page 8 lines 25-27);

depositing a resistance variable material 140 in the opening (figure 1, page 8 lines 27-28);

adding a metal to the resistance variable material 140 to form a metal containing resistance variable material (page 7 lines 12-15); and

forming a second metal electrode 120 in contact with the metal containing resistance variable material (figure 1, page 8 lines 27-28; the second electrode 120 is taught as being metal on page 6 lines 3-10).

'196 does not teach increasing the rigidity of the metal containing resistance variable material.

Sandhu et al. teach a method of forming a resistance variable memory element including depositing a layer of resistance variable material (chalcogenide material deposited, see column 2 lines 56-57); and

subsequently increasing the rigidity of the resistance variable material (after deposition the chalcogenide material is annealed, see column 2 lines 58-59).

Sandhu et al. do not explicitly disclose their annealing step "increasing the rigidity" or the resistance variable material. However, Sandhu et al. disclose a similar material as in the instant application (chalcogenide glass disclosed as selected from the group of Te, Se, Sb, and Ge, see column 1 lines 44-46) and disclose performing an

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similar anneal as in the instant application (the anneal is taught as being at about 250 degrees C for about 10 minutes, see column 5 lines 55-63). Thus it is considered inherent that the annealing process of Sandhu et al. will result in an increase in the rigidity of the variable resistance material.

'196 and Sandhu et al. are combinable because they are from the same field of endeavor. At the time of the invention it would have been obvious to a person of ordinary skill in the art to perform the annealing process of Sandhu et al. which results in increasing the rigidity of the layer in the process of '196. The motivation for doing so is to transform the resistance variable material to a crystalline form by an optimal process to obtain high electrical performance (see Sandhu et al. abstract and title). Therefore, it would have been obvious to combine '196 with Sandhu et al. to obtain the invention of claim 20.

With regard to claim 21, Sandhu et al. teaches the step of increasing the rigidity comprises annealing the resistance variable memory element (annealed as taught on column 5 lines 55-63).

With regard to claim 23, though not explicitly taught by Sandhu et al., it is nonetheless inherently understood that the annealing step comprises heating the resistance variable material to a temperature of about or below the thin-film glass transition temperature of the resistance variable material. This step is inherently taught as the temperature taught for the annealing is about or below the thin-film glass transition temperature of the resistance variable material.

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With regard to claim 24, Sandhu et al. teaches the annealing is disclosed as comprising heating to a temperature in the range from about 200 to about 330 degrees C for a time from about 5 to about 15 minutes (see column 5 lines 55-63).

With regard to claim 25, Sandhu et al. teaches the time period is about 10 minutes.

With regard to claim 27, '196 teaches the resistance variable material comprising a germanium-selenide composition (page 7 lines 4-7).

5. Claims 26, 31 and 32 are rejected under 35 U.S.C. 103(a) as being unpatentable over WO 00/48196 A1 in view of Sandhu et al. (U.S. Patent No. 5,837,564) as applied to claims 20, 21, 23-25 and 27 above, and further in view of APA.

With regards to claims 31 and 32, '196 with Sandhu et al. does not explicitly disclose the resistance variable comprising a germanium-selenide glass wherein the glass layer has a stoichiometry between about Ge<sub>20</sub>Se<sub>80</sub> and Ge<sub>23</sub>Se<sub>77</sub> which has a germanium molar concentration number of equal to or less than about 0.23.

APA teach in paragraphs 4-9 a preferred resistance variable material comprising a germanium-selenide glass comprising silver. APA also teach a germanium-selenide being a preferred variable resistance material (paragraph 6, first line)

With regard to claims 31 and 32, APA teach the germanium-selenide glass having a stoichiometry between about Ge<sub>20</sub>Se<sub>80</sub> and Ge<sub>23</sub>Se<sub>77</sub> which has a germanium molar concentration number of equal to or less than about 0.23 (paragraph 9).

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'196 with Sandhu et al. and APA are combinable because they are from the same field of endeavor. At the time of the invention it would have been obvious to a person of ordinary skill in the art to use the preferred germanium-selenide glass with the claimed composition as the variable resistance material. The motivation for doing so is to allow silver to be directly incorporated into the layer such that the silver can form dendrites and result in nonvolatile change between high and low resistance states, thus allowing for use in a memory cell. Therefore, it would have been obvious to combine '196 with Sandhu et al. and APA to obtain the invention of claims 31 and 32.

With regard to claim 26, in combining the material of APA into the process of '196 with Sandhu et al., the variable resistance material would inherently have a mean coordination number of at least about 2.46. The material and annealing process are similar to that of the instant invention and thus the resulting mean coordination number would inherently be the same.

### Allowable Subject Matter

- 6. Claims 1, 3, 7-19, 22, 28, 29 and 33 are allowed.
- 7. Claim 30 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

## Response to Arguments

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8. Applicant's arguments filed 7/14/04 have been fully considered but they are not persuasive. Applicant has argued that neither Sandhu et al. not the '196 application teach or suggest "increasing the rigidity or the metal containing resistance variable material" as claimed. This is not persuasive as the combination of Sandhu et al, and the '196 application teach increasing the rigidity. As explained in the rejection given with regard to claim 20, in the combination of Sandhu et al. with the '196 application, the same aneal is performed on the same material as in the instant invention and thus the annealing as taught will inherently result in the increased rigidity as claimed. Thus, the references do teach all the limitations claimed and the rejection is considered proper.

#### Conclusion

9. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to N. Drew Richards whose telephone number is (571) 272-1736. The examiner can normally be reached on Monday-Friday 9:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (571) 272-1664. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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